## Notice of References Cited Application/Control No. 10/666,546 Examiner Lynne Edmondson Applicant(s)/Patent Under Reexamination ASHIDA, TAKESHI Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,165,885	12-2000	Gaynes et al.	438/612
*	В	US-5,931,577	08-1999	Ishibashi, Kazuo	362/249
*	С	US-6,622,380	09-2003	Grigg, Ford B.	29/840
*	D	US-2003/0010975	01-2003	Gibb et al.	257/40
*	ш	US-6,630,742	10-2003	Sakuyama, Seiki	257/772
*	F	US-2004/0169288	09-2004	Hsieh et al.	257/780
*	G	US-6,208,791	03-2001	Bischel et al.	385/129
*	Н	US-6,337,445	01-2002	Abbott et al.	174/260
*	Ι	US-6,564,454	05-2003	Glenn et al.	29/852
*	۲	US-2004/0212030	10-2004	Asai, Motoo	257/432
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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